Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/806,520	CHERUKURI ET AL.	
Examiner	Art Unit	
Thinh T Nauven	2818	

SEARCHED				
Class	Subclass	Date	Examiner	
257	686	11/19/2005	TTN	
257	687	11/19/2005	TTN	
257	685	11/20/2005	TTN	
257	723	11/20/2005	TTN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SE (INCLUDIN)	EARCH NOTES G SEARCH STRATEGY	')
	DATE	EXMR
east	11/19/2005	тти
EAST	11/20/2005	TTN